Se	Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/042,100	CRUDELE ET AL.
Examiner	Art Unit
Jude J. Jean-Gilles	2143

SEARCHED				
Class	Subclass	Date	Examiner	
709	224-225	8/4/2005	1G	
713	2	8/4/2005	JG	
717	178	8/4/2005	JG	
707	3	8/4/2005	JG	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
PAM tool: Effective Filing Date Double Patenting	8/4/2005	
EAST tool: DERWENT USPAT EPO JPO	8/4/2005	
Internet: IEEE NPLs onelook.com google.com	8/4/2005	ı,
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